Octal 3-State Non-Inverting Transparent Latch

High-Performance Silicon-Gate CMOS

The MC74HC373A is identical in pinout to the LS373. The device inputs are compatible with standard CMOS outputs; with pullup resistors, they are compatible with LSTTL outputs.

These latches appear transparent to data (i.e., the outputs change asynchronously) when Latch Enable is high. When Latch Enable goes low, data meeting the setup and hold time becomes latched.

The Output Enable input does not affect the state of the latches, but when Output Enable is high, all device outputs are forced to the high-impedance state. Thus, data may be latched even when the outputs are not enabled.

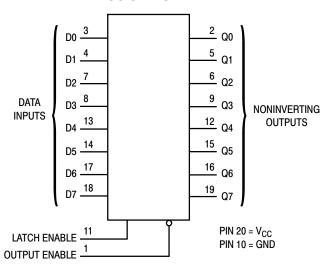
The HC373A is identical in function to the HC573A which has the data inputs on the opposite side of the package from the outputs to facilitate PC board layout.

The HC373A is the non–inverting version of the HC533A.

Features

- Output Drive Capability: 15 LSTTL Loads
- Outputs Directly Interface to CMOS, NMOS and TTL
- Operating Voltage Range: 2.0 to 6.0 V
- Low Input Current: 1.0 μA
- High Noise Immunity Characteristic of CMOS Devices
- In Compliance with the JEDEC Standard No. 7.0 A Requirements
- Chip Complexity: 186 FETs or 46.5 Equivalent Gates
- These Devices are Pb-Free and are RoHS Compliant

LOGIC DIAGRAM





ON Semiconductor®

http://onsemi.com



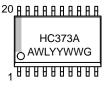


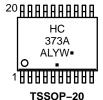
SOIC-20 DW SUFFIX CASE 751D TSSOP-20 DT SUFFIX CASE 948E

PIN ASSIGNMENT

| OUTPUT J | | | |
|----------|----|----|---------------|
| ENABLE 4 | 1● | 20 | V_{CC} |
| Q0 🖣 | 2 | 19 | l Q7 |
| D0 🗗 | 3 | 18 | D7 |
| D1 🖣 | 4 | 17 | D6 |
| Q1 🖣 | 5 | 16 | Q6 |
| Q2 🛭 | 6 | 15 | Q5 |
| D2 🛭 | 7 | 14 | D5 |
| D3 🛭 | 8 | 13 | D4 |
| Q3 🗖 | 9 | 12 | I Q4 |
| GND [| 10 | 11 | LATCH |
| | | | ENABLE |

MARKING DIAGRAMS





SOIC-20

= Assembly Location

WL, L = Wafer Lot YY, Y = Year

WW, W = Work Week G or ■ = Pb-Free Package

(Note: Microdot may be in either location)

FUNCTION TABLE

| | Inputs | Output | |
|--------|--------|--------|-----------|
| Output | Latch | | |
| Enable | Enable | D | Q |
| L | Н | Н | Н |
| L | Н | L | L |
| L | L | Х | No Change |
| H | X | Χ | Z |

X = Don't Care

Z = High Impedance

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

| Design Criteria | Value | Units |
|---------------------------------|--------|-------|
| Internal Gate Count* | 46.5 | ea |
| Internal Gate Propagation Delay | 1.5 | ns |
| Internal Gate Power Dissipation | 5.0 | μW |
| Speed Power Product | 0.0075 | рJ |

^{*}Equivalent to a two-input NAND gate.

MAXIMUM RATINGS

| Symbol | Parameter | Value | Unit |
|------------------|---|--------------------------|------|
| V _{CC} | DC Supply Voltage (Referenced to GND) | -0.5 to +7.0 | V |
| V _{in} | DC Input Voltage (Referenced to GND) | -0.5 to V_{CC} + 0.5 | V |
| V _{out} | DC Output Voltage (Referenced to GND) | -0.5 to V_{CC} + 0.5 | V |
| I _{in} | DC Input Current, per Pin | ±20 | mA |
| l _{out} | DC Output Current, per Pin | ±35 | mA |
| I _{CC} | DC Supply Current, V _{CC} and GND Pins | ±75 | mA |
| P _D | Power Dissipation in Still Air, SOIC Package† TSSOP Package† | 500 450 | mW |
| T _{stg} | Storage Temperature | -65 to +150 | °C |
| TL | Lead Temperature, 1 mm from Case for 10 Seconds (SOIC, SSOP or TSSOP Package) | 260 | °C |

This device contains protection circuitry to guard against damage due to high static voltages or electric fields. However, precautions must be taken to avoid applications of any voltage higher than maximum rated voltages to this high-impedance circuit. For proper operation, V_{in} and V_{out} should be constrained to the range GND \leq (V_{in} or V_{out}) \leq V_{CC} .

Unused inputs must always be tied to an appropriate logic voltage level (e.g., either GND or $V_{\rm CC}$). Unused outputs must be left open.

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

†Derating: SOIC Package: -7 mW/°C from 65° to 125°C TSSOP Package: -6.1 mW/°C from 65° to 125°C

RECOMMENDED OPERATING CONDITIONS

| Symbol | Parameter | | | Max | Unit |
|------------------------------------|--|-------------------------------------|-----------------|--------------------|------|
| V _{CC} | DC Supply Voltage (Referenced to GND) | | 2.0 | 6.0 | V |
| V _{in} , V _{out} | DC Input Voltage, Output Voltage (Referenced to GND) | | 0 | V _{CC} | V |
| T _A | Operating Temperature, All Package Types | | - 55 | +125 | °C |
| t _r , t _f | (Figure 1) | c = 2.0 V c = 4.5 V c = 6.0 V | 0 0 0 | 1000 500 400 | ns |

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

DC ELECTRICAL CHARACTERISTICS (Voltages Referenced to GND)

| | | | | Guar | anteed Lim | it | |
|-----------------|---|---|-----------------|-------------|------------|---------|------|
| Symbol | Parameter | Test Conditions | v _{cc} | −55 to 25°C | ≤ 85°C | ≤ 125°C | Unit |
| V _{IH} | Minimum High-Level Input | $V_{out} = V_{CC} - 0.1 \text{ V}$ | 2.0 | 1.5 | 1.5 | 1.5 | V |
| | Voltage | $ I_{out} \leq 20 \mu A$ | 3.0 | 2.1 | 2.1 | 2.1 | |
| | | | 4.5 | 3.15 | 3.15 | 3.15 | |
| | | | 6.0 | 4.2 | 4.2 | 4.2 | |
| V _{IL} | Maximum Low-Level Input | $V_{out} = 0.1 \text{ V}$ | 2.0 | 0.5 | 0.5 | 0.5 | V |
| | Voltage | $ I_{\text{out}} \leq 20 \mu\text{A}$ | 3.0 | 0.9 | 0.9 | 0.9 | |
| | | 1, 223 | 4.5 | 1.35 | 1.35 | 1.35 | |
| | | | 6.0 | 1.8 | 1.8 | 1.8 | |
| V _{OH} | Minimum High-Level Output | $V_{in} = V_{IH}$ | 2.0 | 1.9 | 1.9 | 1.9 | V |
| | Voltage | $ I_{out} \leq 20 \mu A$ | 4.5 | 4.4 | 4.4 | 4.4 | |
| | | | 6.0 | 5.9 | 5.9 | 5.9 | |
| | | $V_{in} = V_{IH}$ $ I_{out} \le 2.4 \text{ mA}$ | 3.0 | 2.48 | 2.34 | 2.2 | |
| | | $ I_{\text{out}} \le 6.0 \text{ mA}$ | 4.5 | 3.98 | 3.84 | 3.7 | |
| | | $ I_{out} \le 7.8 \text{ mA}$ | 6.0 | 5.48 | 5.34 | 5.2 | |
| V _{OL} | Maximum Low-Level Output | $V_{in} = V_{IL}$ | 2.0 | 0.1 | 0.1 | 0.1 | V |
| | Voltage | $ I_{out} \leq 20 \mu A$ | 4.5 | 0.1 | 0.1 | 0.1 | |
| | | | 6.0 | 0.1 | 0.1 | 0.1 | |
| | | $V_{in} = V_{IL}$ $ I_{out} \le 2.4 \text{ mA}$ | 3.0 | 0.26 | 0.33 | 0.4 | |
| | | $ I_{out} \le 6.0 \text{ mA}$ | 4.5 | 0.26 | 0.33 | 0.4 | |
| | | $ I_{out} \le 7.8 \text{ mA}$ | 6.0 | 0.26 | 0.33 | 0.4 | |
| I _{in} | Maximum Input Leakage Current | V _{in} = V _{CC} or GND | 6.0 | ±0.1 | ±1.0 | ±1.0 | μΑ |
| l _{OZ} | Maximum Three–State | Output in High-Impedance State | 6.0 | ±0.5 | ±5.0 | ±10 | μΑ |
| | Leakage Current | $V_{in} = V_{IL} \text{ or } V_{IH}$ $V_{out} = V_{CC} \text{ or GND}$ | | | | | |
| I _{CC} | Maximum Quiescent Supply Current (per Package) | $V_{in} = V_{CC}$ or GND $I_{out} = 0 \mu A$ | 6.0 | 4.0 | 40 | 160 | μА |

AC ELECTRICAL CHARACTERISTICS ($C_L = 50 \ pF$, Input $t_r = t_f = 6.0 \ ns$)

| | | V _{CC} | Guar | | | |
|------------------|---|-----------------|-------------|------------------------|---------|------|
| Symbol | Parameter | v | –55 to 25°C | ≤ 85 ° C | ≤ 125°C | Unit |
| t _{PLH} | Maximum Propagation Delay, Input D to Q | 2.0 | 125 | 155 | 190 | ns |
| t _{PHL} | (Figures 1 and 5) | 3.0 | 80 | 110 | 130 | |
| | | 4.5 | 25 | 31 | 38 | |
| | | 6.0 | 21 | 26 | 32 | |
| t _{PLH} | Maximum Propagation Delay, Latch Enable to Q | 2.0 | 140 | 175 | 210 | ns |
| t _{PHL} | (Figures 2 and 5) | 3.0 | 90 | 120 | 140 | |
| | | 4.5 | 28 | 35 | 42 | |
| | | 6.0 | 24 | 30 | 36 | |
| t _{PLZ} | Maximum Propagation Delay, Output Enable to Q | 2.0 | 150 | 190 | 225 | ns |
| t _{PHZ} | (Figures 3 and 6) | 3.0 | 100 | 125 | 150 | |
| | | 4.5 | 30 | 38 | 45 | |
| | | 6.0 | 26 | 33 | 38 | |
| t _{PZL} | Maximum Propagation Delay, Output Enable to Q | 2.0 | 150 | 190 | 225 | ns |
| t _{PZH} | (Figures 3 and 6) | 3.0 | 100 | 125 | 150 | |
| | | 4.5 | 30 | 38 | 45 | |
| | | 6.0 | 26 | 33 | 38 | |
| t _{TLH} | Maximum Output Transition Time, Any Output | 2.0 | 60 | 75 | 90 | ns |
| t _{THL} | (Figures 1 and 5) | 3.0 | 23 | 27 | 32 | |
| | | 4.5 | 12 | 15 | 18 | |
| | | 6.0 | 10 | 13 | 15 | |
| C _{in} | Maximum Input Capacitance | | 10 | 10 | 10 | pF |
| C _{out} | Maximum Three–State Output Capacitance (Output in High–Impedance State) | | 15 | 15 | 15 | pF |

| Ī | | | Typical @ 25°C, V _{CC} = 5.0 V | |
|---|----------|---|---|----|
| | C_{PD} | Power Dissipation Capacitance (Per Enabled Output)* | 36 | pF |

^{*} Used to determine the no–load dynamic power consumption: $P_D = C_{PD} V_{CC}^2 f + I_{CC} V_{CC}$.

TIMING REQUIREMENTS ($C_L = 50 \text{ pF}$, Input $t_r = t_f = 6.0 \text{ ns}$)

| | | | | Guaranteed Limit | | | | | | | | | | |
|---------------------------------|---|--------|--------------------------|--------------------------|---------------------------|--------------------------|---------------------------|--------------------------|---------------------------|------|-----|---------|--|--|
| | | | V _{CC} | -55 to | –55 to 25°C | | –55 to 25°C | | 25°C ≤ 85°C | | 5°C | ≤ 125°C | | |
| Symbol | Parameter | Figure | Volts | Min | Max | Min | Max | Min | Max | Unit | | | | |
| t _{su} | Minimum Setup Time, Input D to Latch Enable | 4 | 2.0 3.0 4.5 6.0 | 25 20 5.0 5.0 | | 30 25 6.0 6.0 | | 40 30 8.0 7.0 | | ns | | | | |
| t _h | Minimum Hold Time, Latch Enable to Input D | 4 | 2.0 3.0 4.5 6.0 | 5.0 5.0 5.0 5.0 | | 5.0 5.0 5.0 5.0 | | 5.0 5.0 5.0 5.0 | | ns | | | | |
| t _w | Minimum Pulse Width, Latch Enable | 2 | 2.0 3.0 4.5 6.0 | 60 23 12 10 | | 75 27 15 13 | | 90 32 18 15 | | ns | | | | |
| t _r , t _f | Maximum Input Rise and Fall Times | 1 | 2.0 3.0 4.5 6.0 | | 1000 800 500 400 | | 1000 800 500 400 | | 1000 800 500 400 | ns | | | | |

SWITCHING WAVEFORMS

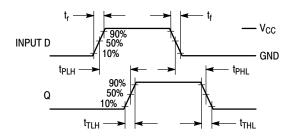


Figure 1.

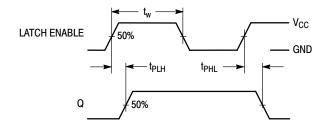


Figure 2.

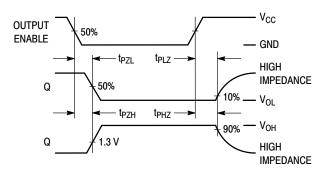


Figure 3.

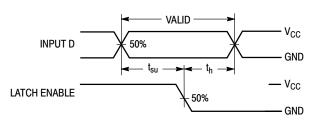
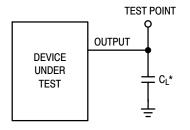
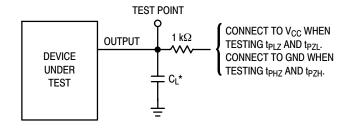


Figure 4.

TEST CIRCUITS





*Includes all probe and jig capacitance

Figure 5.

Figure 6.

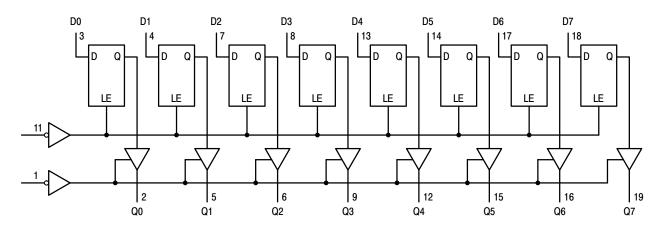


Figure 7. Expanded Logic Diagram

ORDERING INFORMATION

| Device | Package | Shipping [†] |
|-----------------|---------------------------|-----------------------|
| MC74HC373ADWG | SOIC-20 WIDE (Pb-Free) | 38 Units / Rail |
| MC74HC373ADWR2G | SOIC-20 WIDE (Pb-Free) | 1000 Units / Reel |
| MC74HC373ADTG | TSSOP-20 (Pb-Free) | 75 Units / Rail |
| MC74HC373ADTR2G | TSSOP-20 (Pb-Free) | 2500 Units / Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

^{*}Includes all probe and jig capacitance

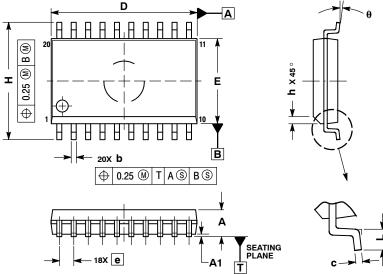




SOIC-20 WB CASE 751D-05 **ISSUE H**

DATE 22 APR 2015

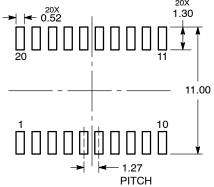
SCALE 1:1



- DIMENSIONS ARE IN MILLIMETERS.
 INTERPRET DIMENSIONS AND TOLERANCES.
- PER ASME Y14.5M, 1994.
 3. DIMENSIONS D AND E DO NOT INCLUDE MOLD
- PROTRUSION.
 MAXIMUM MOLD PROTRUSION 0.15 PER SIDE.
- DIMENSION B DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE PROTRUSION SHALL BE 0.13 TOTAL IN EXCESS OF B DIMENSION AT MAXIMUM MATERIAL

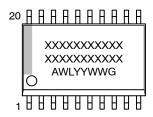
| | MILLIMETERS | | | |
|-----|-------------|-------|--|--|
| DIM | MIN | MAX | | |
| Α | 2.35 | 2.65 | | |
| A1 | 0.10 | 0.25 | | |
| b | 0.35 | 0.49 | | |
| С | 0.23 | 0.32 | | |
| D | 12.65 | 12.95 | | |
| E | 7.40 | 7.60 | | |
| е | 1.27 | BSC | | |
| Н | 10.05 | 10.55 | | |
| h | 0.25 | 0.75 | | |
| L | 0.50 | 0.90 | | |
| A | 0 ° | 7 ° | | |

RECOMMENDED SOLDERING FOOTPRINT*



DIMENSIONS: MILLIMETERS

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location

WL = Wafer Lot ΥY = Year WW = Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

| | DOCUMENT NUMBER: | 98ASB42343B | Electronic versions are uncontrolled except when accessed directly from the Documen Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red. | | |
|---|------------------|-------------|--|-------------|--|
| I | DESCRIPTION: | SOIC-20 WB | | PAGE 1 OF 1 | |

ON Semiconductor and unare trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.



TSSOP-20 WB CASE 948E ISSUE D

DATE 17 FEB 2016





NOTES:

- DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: MILLIMETER.
- 3. DIMENSION A DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
- FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE. DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE. DIMENSION K DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE K
- (0.003) TOTAL IN EXCESS OF THE K DIMENSION AT MAXIMUM MATERIAL CONDITION.
- TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.

 7. DIMENSION A AND B ARE TO BE
- DETERMINED AT DATUM PLANE -W-

| | MILLIMETERS | | INCHES | |
|-----|-------------|------|-----------|-------|
| DIM | MIN | MAX | MIN | MAX |
| Α | 6.40 | 6.60 | 0.252 | 0.260 |
| В | 4.30 | 4.50 | 0.169 | 0.177 |
| С | | 1.20 | | 0.047 |
| D | 0.05 | 0.15 | 0.002 | 0.006 |
| F | 0.50 | 0.75 | 0.020 | 0.030 |
| G | 0.65 BSC | | 0.026 BSC | |
| Н | 0.27 | 0.37 | 0.011 | 0.015 |
| J | 0.09 | 0.20 | 0.004 | 0.008 |
| J1 | 0.09 | 0.16 | 0.004 | 0.006 |
| K | 0.19 | 0.30 | 0.007 | 0.012 |
| K1 | 0.19 | 0.25 | 0.007 | 0.010 |
| L | 6.40 BSC | | 0.252 BSC | |
| M | 0° | 8° | 0° | 8° |

SOLDERING FOOTPRINT



GENERIC MARKING DIAGRAM*



= Assembly Location

= Wafer Lot

= Year

= Work Week

= Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

| DOCUMENT NUMBER: 98ASH70169A | | Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red. | | |
|------------------------------|-------------|---|-------------|--|
| DESCRIPTION: | TSSOP-20 WB | | PAGE 1 OF 1 | |

ON Semiconductor and un are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer pu

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:
Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for Latches category:

Click to view products by ON Semiconductor manufacturer:

Other Similar products are found below:

ML4875CS-5 401639B 716165RB 74F373DW 74LVC373ADTR2G 74LVC573ADTR2G NL17SG373DFT2G NLV14044BDG 5962-8863901RA 5962-88639012A NLV14042BDR2G M22W-1333-21/3/45-90-02 (NI 2.L18.001-21 2.T18.001-21 2.T18.002-18 2.T18.006-18 CQ/AA-KEY CQ/A-M22X1,5-45-28 CQ/A-M22X1,5-45-32 M22-2-D5-2-21-01-P CY74FCT2373CTSOC 421283 MM74HC373WM MM74HC573WM 74LCX373MTC 74LVT16373MTDX 74VHC373MX KLD5.001-02 Z-0233-827-15 MIC58P01YV 74AHCT573D.112 74LCX16373MTDX CQ/A-M22X1,5-45-16 CQ/A-M22X1,5-45-18 CQ/A-M22X1,5-45-20 CQ/A-M22X1,5-45-24 CQ/A-M22X1,5-45-30 CQT/A-32-18 AE-V0 CQT/A-32 20-AE-V0 CQT/A-32 32-AE-V0 CY54FCT841ATDMB TPIC6B273DWRG4 Z-2106-25001-22 2.904.005 2.904.006 2.904.008 TC74HC573APF 74HC373DB.112 HEF4043BT.652 2.KLB-D5.001PA-07